Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/925,231	AWAD ET AL.	
Examiner	Art Unit	
Jia W. Lu	2634	

	SEAR	CHED	
Class	Subclass	Date	Examiner
375	231	11/3/2004	JL .
375	232	11/3/2004	JL
375	233	11/3/2004	JL
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INT	ERFEREN	E SEARCHED	
Class	Subclass	Date	Examiner
375	232	11/3/2004	JL

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	11/3/2004	JL
INVENTORSHIP	11/2/2004	JL
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